

SN54BCT543, SN74BCT543 OCTAL REGISTERED TRANSCEIVERS WITH 3-STATE OUTPUTS

D3199, NOVEMBER 1988

- 3-State True Outputs
- Back-to-Back Registers for Storage
- Package Options Include Plastic "Small Outline" Packages, Ceramic Chip Carriers and Standard Plastic and Ceramic 300-mil DIPs

description

The 'BCT543 octal transceiver contains two sets of D-type latches for temporary storage of data flowing in either direction. Separate Latch Enable (\overline{LEAB} or \overline{LEBA}) and Output Enable (\overline{GAB} or \overline{GBA}) inputs are provided for each register to permit independent control in either direction of data flow.

The A-to-B Enable (\overline{CEAB}) input must be low in order to enter data from A or to output data from B. Having \overline{CEAB} low and \overline{LEAB} low makes the A-to-B latches transparent; a subsequent low-to-high transition of \overline{LEAB} puts the A latches in the storage mode. With \overline{CEAB} and \overline{GAB} both low, the 3-state B outputs are active and reflect the data present at the output of the A latches. Data flow from B to A is similar, but requires using the \overline{CEBA} , \overline{LEBA} , and \overline{GBA} inputs.

The SN54BCT543 is characterized for operation over the full military temperature range of -55°C to 125°C . The SN74BCT543 is characterized for operation from 0°C to 70°C .

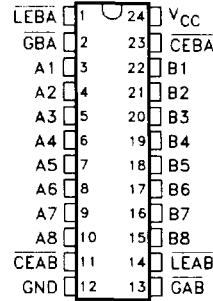
FUNCTION TABLE

INPUTS				OUTPUTS	LATCH STATUS
\overline{GAB}	\overline{CEAB}	\overline{LEAB}	DATA	B1 THRU B8	A TO B [†]
H	X	X	X	Z	OUTPUTS DISABLED
L	H	L	L	Z	OUTPUTS DISABLED
L	H	L	H	Z	DATA LATCHED
L	L	H	H	L	DATA LATCHED [‡]
L	L	H	H	H	DATA LATCHED [‡]
L	L	L	L	L	TRANSPARENT
L	L	L	H	H	TRANSPARENT

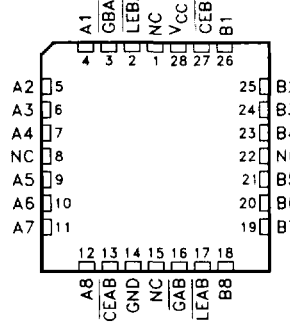
[†] A-to-B data flow is shown; B-to-A flow control is the same except uses \overline{CEBA} , \overline{LEBA} , and \overline{GBA} .

[‡] Data present before low-to-high transition of \overline{LEAB} .

SN54BCT543 ... JT PACKAGE
SN74BCT543 ... DW OR NT PACKAGE
(TOP VIEW)



SN54BCT543 ... FK PACKAGE
(TOP VIEW)



NC—No internal connection

2

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PRODUCTION DATA documents contain information current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.

TEXAS
INSTRUMENTS

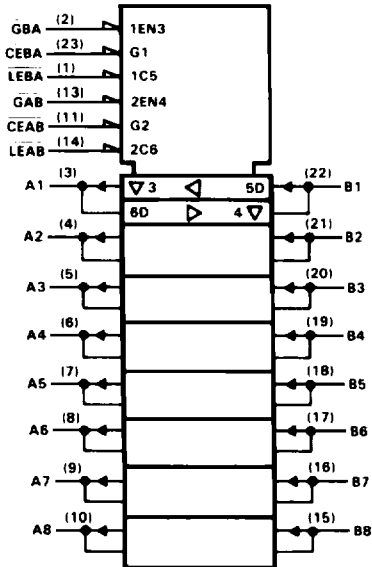
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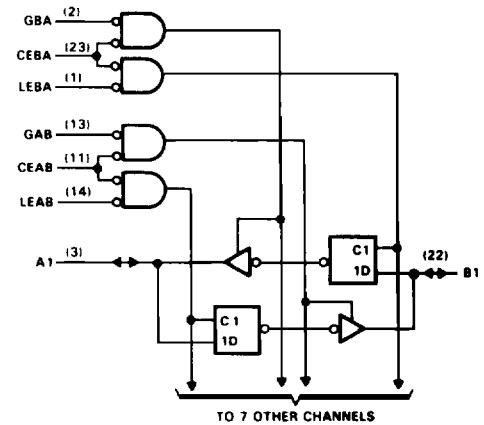
SN54BCT543, SN74BCT543
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WITH 3-STATE OUTPUTS

logic symbol†



† This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

logic diagram (positive logic)



Pin numbers shown are for DW, JT, and NT packages.

2

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)‡

Supply voltage, VCC	-0.5 V to 7 V
Input voltage (I/O ports) (see Note 1)	-0.5 V to 5.5 V
Input voltage (Excluding I/O ports) (see Note 1)	-0.5 V to 7 V
Voltage applied to any output in the high state	-0.5 V to VCC
Input clamp current	-30 mA
Current into any output in the low state: SN54BCT543	96 mA
SN74BCT543	128 mA
Operating free-air temperature range: SN54BCT543	-55°C to 125°C
SN74BCT543	0°C to 70°C
Storage temperature range	-65°C to 150°C

‡ Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: The input negative voltage rating may be exceeded if the input clamp current rating is observed.

SN54BCT543, SN74BCT543
OCTAL REGISTERED TRANSCEIVERS
WITH 3-STATE OUTPUTS

recommended operating conditions

	SN54BCT543			SN74BCT543			UNIT
	MIN	NOM	MAX	MIN	NOM	MAX	
V _{CC} Supply voltage	4.5	5	5.5	4.5	5	5.5	V
V _{IH} High-level input voltage	2			2			V
V _{IL} Low-level input voltage			0.8			0.8	V
I _{IK} Input clamp current			-18			-18	mA
I _{OH} High-level output current			-12			-15	mA
I _{OL} Low-level output current			48			64	mA
T _A Operating free-air temperature	-55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	SN54BCT543			SN74BCT543			UNIT	
		MIN	TYP†	MAX	MIN	TYP†	MAX		
V _{IK}	V _{CC} = 4.5 V, I _I = -18 mA			-1.2			-1.2	V	
V _{OH}	V _{CC} = 4.5 V	I _{OH} = -3 mA	2.4	3.3	2.4	3.3		V	
		I _{OH} = -12 mA	2	3.2					
		I _{OH} = -15 mA			2	3.1			
V _{OL}	V _{CC} = 4.5 V	I _{OL} = 48 mA		0.38	0.55			V	
		I _{OL} = 64 mA				0.42	0.55		
I _I	V _{CC} = 5.5 V, V _I = 5.5 V			0.4			0.4	mA	
I _{IH} ‡	Control inputs A and B V _{CC} = 5.5 V, V _I = 2.7 V			20			20	μA	
				70			70		
I _{IL} ‡	Control inputs A and B V _{CC} = 5.5 V, V _I = 0.5 V			-0.6			-0.6	mA	
				-0.65			-0.65		
I _{OS} ‡	V _{CC} = 5.5 V, V _O = 0			-100			-225	mA	
I _{CCL}	V _{CC} = 5.5 V			45	71		45	71	mA
I _{CCH}	V _{CC} = 5.5 V			5	8		5	8	mA
I _{CCZ}	V _{CC} = 5.5 V			9	15		5	15	mA
C _i	Control inputs V _{CC} = 5 V, V _I = 2.5 V or 0.5 V			6			6	pF	
C _{io}	A and B V _{CC} = 5 V, V _I = 2.5 V or 0.5 V			16			16	pF	

† All typical values are at V_{CC} = 5 V, T_A = 25°C.

‡ Not more than one output should be shorted at a time and the duration of the short circuit should not exceed one second.

§ For I/O ports, the parameters I_{IH} and I_{IL} include the off-state output current.

2

BiCMOS Circuits



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OCTAL REGISTERED TRANSCEIVERS
WITH 3-STATE OUTPUTS

timing requirements

	VCC = 5 V, TA = 25°C	VCC = 4.5 V to 5.5 V, TA = MIN TO MAX†				UNIT		
		'BCT543		SN54BCT543			SN74BCT543	
		MIN	MAX	MIN	MAX		MIN	MAX
t _{su} Setup time, data before latch enable ↑	4.5		4.5		4.5	ns		
t _h Hold time, data after latch enable ↑	1.5		1.5		1.5	ns		
t _w Pulse duration, latch enable low	7		7		7	ns		

switching characteristics (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	VCC = 5 V, CL = 50 pF, R1 = 500 Ω, R2 = 500 Ω, TA = 25°C			VCC = 4.5 V to 5.5 V, CL = 50 pF, R1 = 500 Ω, R2 = 500 Ω, TA = MIN TO MAX†				UNIT
			'BCT543			SN54BCT543		SN74BCT543		
			MIN	TYP	MAX	MIN	MAX	MIN	MAX	
t _{PLH}	A or B	B or A	2	5.7	7.5	2	9.9	2	8.8	ns
t _{PHL}			2	6.3	8.2	2	9.7	2	9.6	
t _{PLH}	ĪE	A or B	2	8.2	10.3	2	13.9	2	12.9	ns
t _{PHL}			2	8.5	10.6	2	13.2	2	12.7	
t _{PZH}	G	A or B	1	6.8	8.6	1	11.4	1	10.7	ns
t _{PZL}			1	8.7	10.8	1	12.8	1	12.3	
t _{PHZ}	G	A or B	1	5.5	7.2	1	8.8	1	8.1	ns
t _{PLZ}			1	4.7	6.4	1	8.1	1	7.2	
t _{PZH}	OE	A or B	1	7.6	9.8	1	12.8	1	12	ns
t _{PZL}			1	9.5	11.6	1	13.8	1	13.5	
t _{PHZ}	OE	A or B	1	5.8	7.5	1	9.3	1	8.5	ns
t _{PLZ}			1	4.8	6.7	1	8.4	1	7.6	

† For conditions shown as MIN or MAX, use the appropriate value specified under Recommended Operating Conditions.

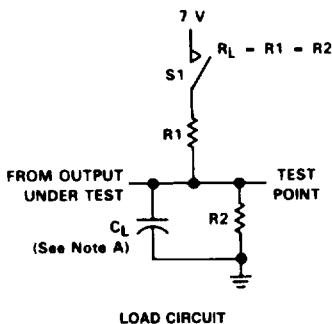
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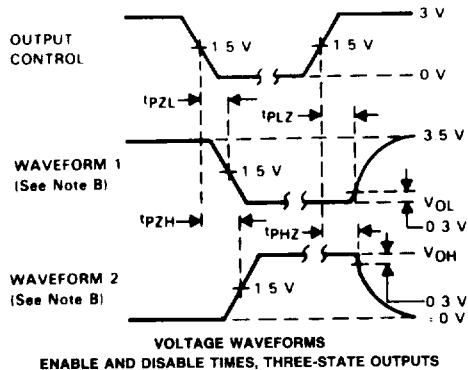
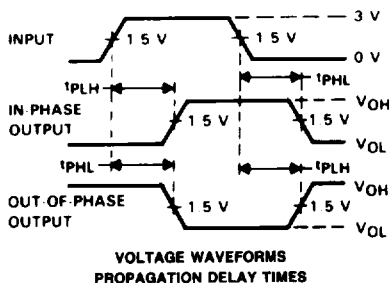
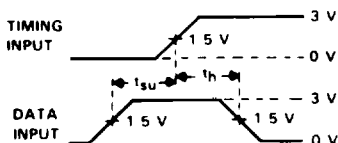
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PARAMETER MEASUREMENT INFORMATION



SWITCH POSITION TABLE

TEST	S1
t_{PLH}	Open
t_{PHL}	Open
t_{PZH}	Open
t_{PZL}	Closed
t_{PHZ}	Open
t_{PLZ}	Closed



- NOTES: A. C_L includes probe and jig capacitance.
 B. Input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, $Z_0 = 50 \Omega$, $t_r = 2.5$ ns, $t_f = 2.5$ ns.
 C. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control.
 Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
 D. The outputs are measured one at a time with one input transition per measurement.

FIGURE 1. SWITCHING CHARACTERISTICS